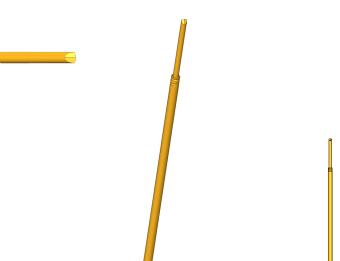
Test Probe INGUN E-Type

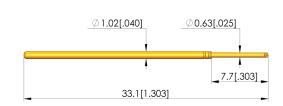
E-075 238 064 A 2800

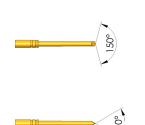
Item E-075-0099



- Highest contact reliability under challenging test conditions without additional stress on the DUT: up to 25% larger contact surface between test probe and DUT
- When hitting the test surface a spring force up to 100% higher than a standard GKS is available, but the same spring force as a standard GKS is achieved at the working stroke.







1:1

General data

Product group: ICT / FCT (in-circuit test and function test Sub-product group: INGUN E-TYPE® Series: E-075 Grid: 1.91 mm [75.1 mil]

Contacting from: Magnetic: Yes Installation type: Plug-in Quick-exchange system: Yes Adjustable installation height: No Non-rotating: No Compatible receptacle(s): KS-075 Min. temperature: -40 °C [-40 °F] Max. temperature: 80 °C [176 °F] RoHS-compliant: Yes

Tip style data

Tip style: 38 150° passive dagger, self-cleaning
Tip diameter: 0.64 mm [.025 in]
Tip style surface: A gold
Tip style material: 2 steel

Electrical data

Current load capacity / rated current: 3 A
Typical resistance (Ri): 20 mOhm

Mechanical data

 Total length:
 33.1 mm [1.3 in]

 Barrel diameter:
 1.02 mm [.04 in]

 Maximum stroke:
 6.35 mm [.25 in]

 Spring pre-load:
 1.46 N [5.25 ozf]

 Collar height:
 00

 Spring force at working stroke:
 2.8 N [10 ozf]

 Recommended working stroke:
 4.3 mm [.169 in]

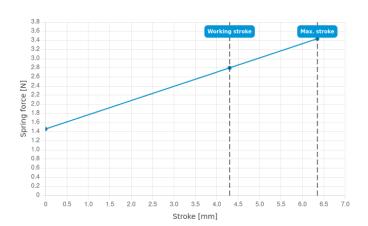
Partner for Future Technology

Test Probe INGUN E-Type

E-075 238 064 A 2800

Item E-075-0099





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Learn more about **ICT/FCT Test probes**



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